



2814

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re PATENT APPLICATION of

Kyoung-Yoon Baek et al.

Group Art Unit: 2814

Serial No.: 10/043,329

Examiner: Rao, Shrinivas H.

Filed: 14 January 2002

For: OVERLAY KEY, METHOD OF  
MANUFACTURING THE SAME AND  
METHOD OF MEASURING AN  
OVERLAY DEGREE USING THE  
SAME

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TC 2800 MAIL ROOM

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**RESPONSE TO ELECTION/RESTRICTION REQUIREMENT**

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Sir:

In response to the Office Action of 29 September 2003, Applicants elect the invention of Group I, Claims 1-24, drawn to an overlay key. The election is without traverse.

Respectfully submitted,

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